

APPENDIX 3: Photographs of test setup

Radiated Spurious Emission
(Below 1GHz)



Photo 1



Photo 2

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Radiated Spurious Emission
(Above 1GHz)

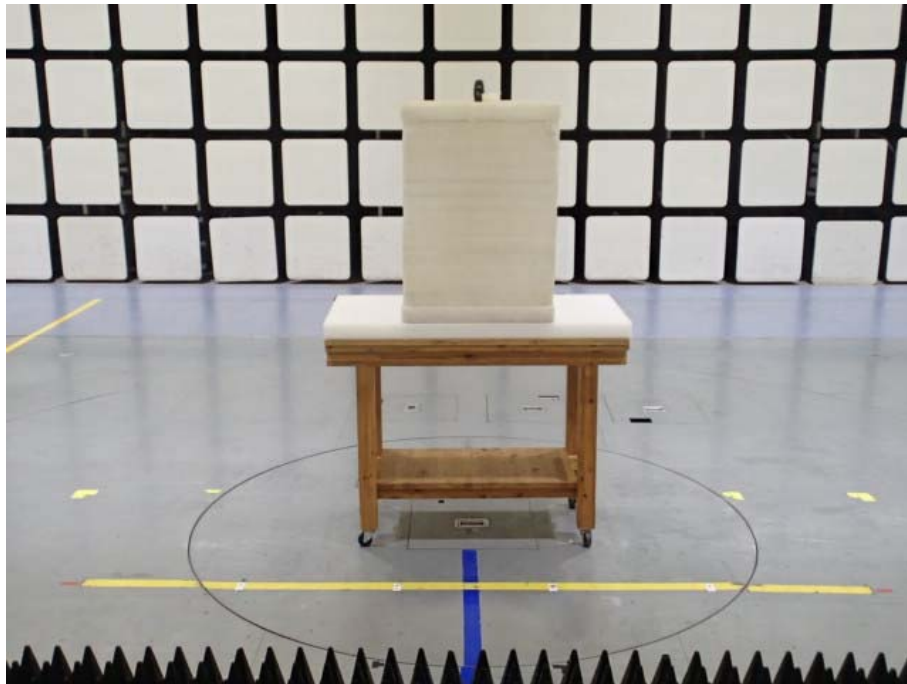


Photo 1

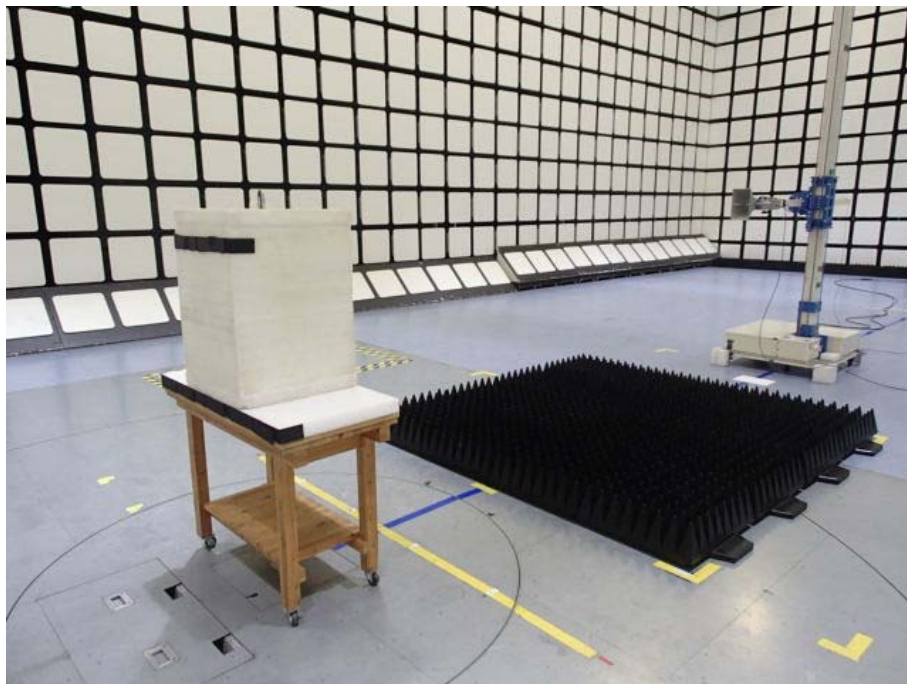


Photo 2

Worst Case Position

Below 1 GHz: (Horizontal: Z-axis / Vertical: Y-axis)

Above 1 GHz: (Horizontal: Y-axis / Vertical: Z-axis)

X-axis



Y-axis



Z-axis



Worst Case Position



With mechanical key inserted (Worst)



Without mechanical key inserted

End of Report

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